				NT OF COMMERCE IADEMARK OFFICE	ATTY. DOCKET NO. MI22-1896			SERIAL NO. 10/050,373		
	APPLICANT: Gurtej S. Sandhu, et al.									
Obse seven sheets if necessary)					FILING DATE January 15, 2002			ART GROUP 2813		
U.S. PATENT	000	THE BADSON								
'Examiner's Initials		Document Number	Date	Name		Class	Subcla	155	Filing Date If Appropriate	
	NA.	7,153,736 B2	12/2006	Eppich et al.						
	AВ	7,153,746 B2	12/2006	Moore et al.						
	AC									
	AD.									
Ā	AΕ									
,	AF.									
4	4G									
	АН									
	AJ									
	٩J									
	AK .									
,	AL.									
FOREIGN PAT	EIGN PATENT DOCUMENTS Document Date Country Class Subclass Translation									
		Number	Date	Country		Class	Subcia		Yes	No
4	AL.	US02/38233	11/2002	PCT-Int'l Preliminary Exam Report						
	M	US02/38233	11/2002	PCT-Int'l Search Re	eport					11 14
OTHER REFER	RENC	DES (including Author,	Title, Date, Pe	ertinent Pages, Etc.)						
A	W	Millman, MICROELECTRONICS, ⊚ 1979; Sec. 4-1; pgs 91-92,								
A	10			-						
EXAMINER DATE CONSIDERED /Laura Schillinger/ (05/20/2008)										
*EXAMINER; Init considered, Inclu	ial if re	elerence considered, whet py of this form with next co	her or not citation mmunication to	on is in conformance with MP applicant.	EP 609; Draw line	through cita	ation if no	t in confo	ormance	and not